

SIPMOS® Small-Signal-Transistor

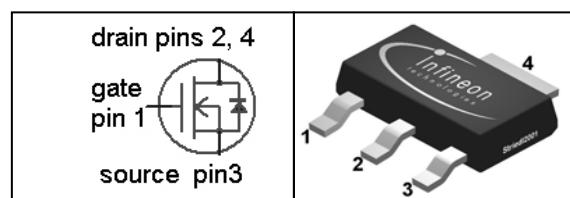
Features

- N-channel
- Depletion mode
- dv/dt rated
- Available with $V_{GS(th)}$ indicator on reel
- Pb-free lead plating; RoHS compliant

Product Summary

V_{DS}	600	V
$R_{DS(on),max}$	60	Ω
$I_{DSS,min}$	0.02	A

PG-SOT-223



Type	Package	Tape and Reel Information	Marking
BSP135	PG-SOT-223	L6327: 1000 pcs/reel	BSP135
BSP135	PG-SOT-223	L6906: 1000 pcs/reel sorted in $V_{GS(th)}$ bands ¹⁾	BSP135

Maximum ratings, at $T_j=25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_A=25$ °C	0.12	A
		$T_A=70$ °C	0.10	
Pulsed drain current	$I_{D,pulse}$	$T_A=25$ °C	0.48	
Reverse diode dv/dt	dv/dt	$I_D=0.12$ A, $V_{DS}=20$ V, $di/dt=200$ A/ μ s, $T_{j,max}=150$ °C	6	kV/ μ s
Gate source voltage	V_{GS}		± 20	V
ESD sensitivity (HBM) as per MIL-STD 883			Class 1	
Power dissipation	P_{tot}	$T_A=25$ °C	1.8	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

¹⁾ see table on next page and diagram 11

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - soldering point (pin 4)	R_{thJS}		-	-	25	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	115	
		6 cm ² cooling area ²⁾	-	-	70	

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=-3$ V, $I_D=250$ µA	600	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=3$ V, $I_D=94$ µA	-2.1	-1.4	-1	
Drain-source cutoff current	$I_{D(off)}$	$V_{DS}=600$ V, $V_{GS}=-3$ V, $T_j=25$ °C	-	-	0.1	µA
		$V_{DS}=600$ V, $V_{GS}=-3$ V, $T_j=125$ °C	-	-	10	
Gate-source leakage current	I_{GSS}	$V_{GS}=20$ V, $V_{DS}=0$ V	-	-	100	nA
On-state drain current	I_{DSS}	$V_{GS}=0$ V, $V_{DS}=10$ V	20	-	-	mA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=0$ V, $I_D=0.01$ A	-	30	60	Ω
		$V_{GS}=10$ V, $I_D=0.12$ A	-	25	45	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max},$ $I_D=0.1$ A	0.08	0.16	-	s

Threshold voltage $V_{GS(th)}$ sorted in bands³⁾

J	$V_{GS(th)}$	$V_{DS}=3$ V, $I_D=94$ µA	-1.2	-	-1	V
K			-1.35	-	-1.15	
L			-1.5	-	-1.3	
M			-1.65	-	-1.45	
N			-1.8	-	-1.6	

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (single layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ Each reel contains transistors out of one band whose identifying letter is printed on the reel label. A specific band cannot be ordered separately.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=-3\text{ V}, V_{DS}=25\text{ V}, f=1\text{ MHz}$	-	98	146	pF
Output capacitance	C_{oss}		-	8.5	13	
Reverse transfer capacitance	C_{rss}		-	3.4	5.1	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=300\text{ V}, V_{GS}=-3\text{...}5\text{ V}, I_D=0.1\text{ A}, R_G=6\Omega$	-	5.4	8.1	ns
Rise time	t_r		-	5.6	8.4	
Turn-off delay time	$t_{d(off)}$		-	28	42	
Fall time	t_f		-	182	273	

Gate Charge Characteristics

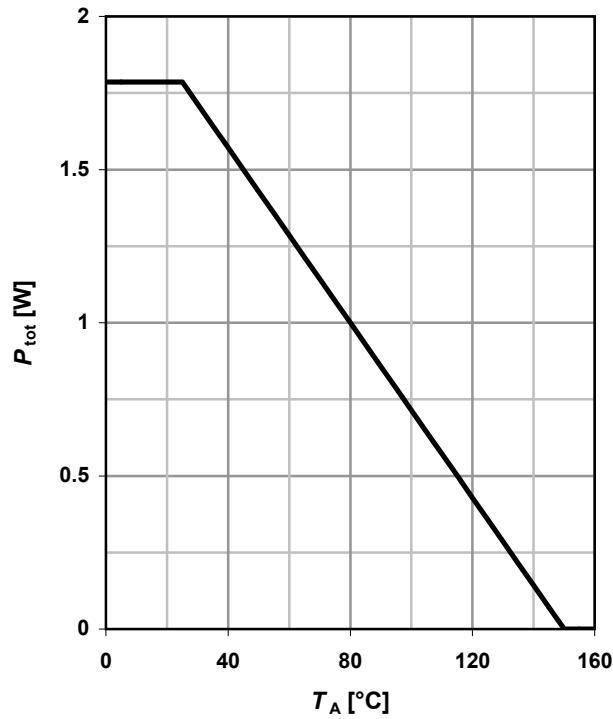
Gate to source charge	Q_{gs}	$V_{DD}=400\text{ V}, I_D=0.1\text{ A}, V_{GS}=-3\text{ to }5\text{ V}$	-	0.24	0.36	nC
Gate to drain charge	Q_{gd}		-	2.0	3.0	
Gate charge total	Q_g		-	3.7	4.9	
Gate plateau voltage	$V_{plateau}$		-	0.20	-	

Reverse Diode

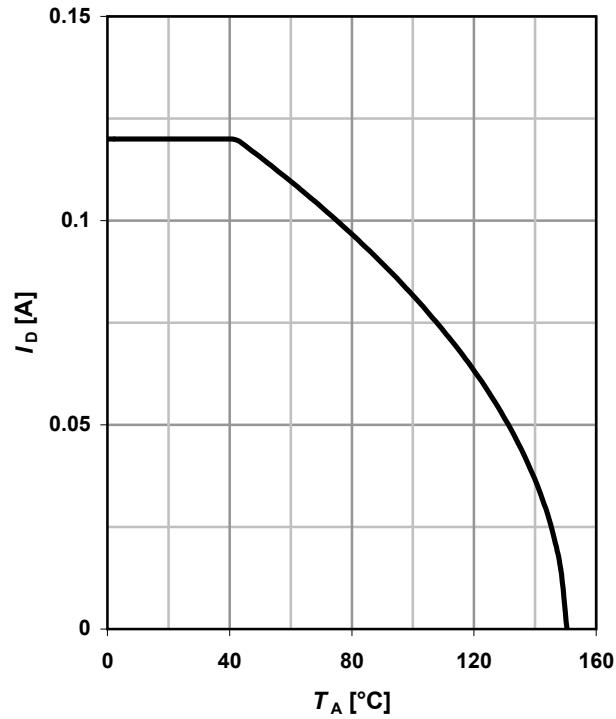
Diode continuous forward current	I_S	$T_A=25\text{ }^\circ\text{C}$	-	-	0.12	A
Diode pulse current	$I_{S,pulse}$		-	-	0.48	
Diode forward voltage	V_{SD}	$V_{GS}=-3\text{ V}, I_F=0.12\text{ A}, T_j=25\text{ }^\circ\text{C}$	-	0.78	1.2	V
Reverse recovery time	t_{rr}	$V_R=300\text{ V}, I_F=0.1\text{ A}, di_F/dt=100\text{ A}/\mu\text{s}$	-	87	130	ns
Reverse recovery charge	Q_{rr}		-	70	104	

1 Power dissipation

$$P_{\text{tot}} = f(T_A)$$

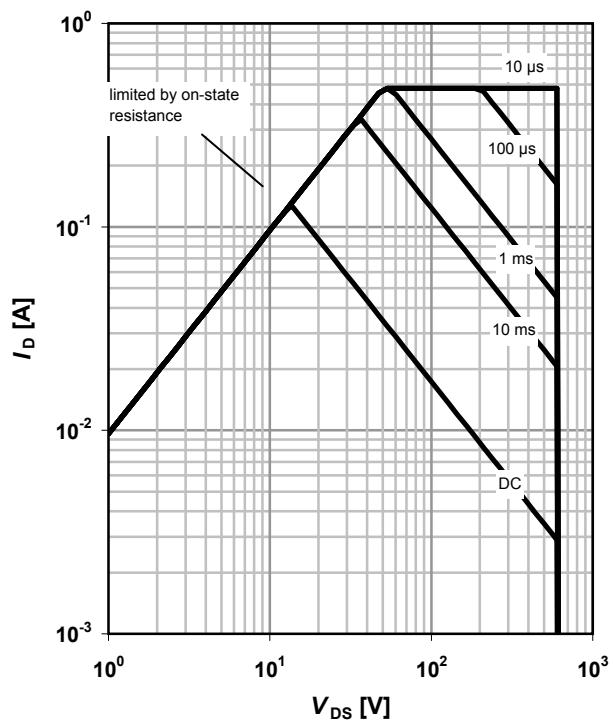

2 Drain current

$$I_D = f(T_A); V_{GS} \geq 10 \text{ V}$$


3 Safe operating area

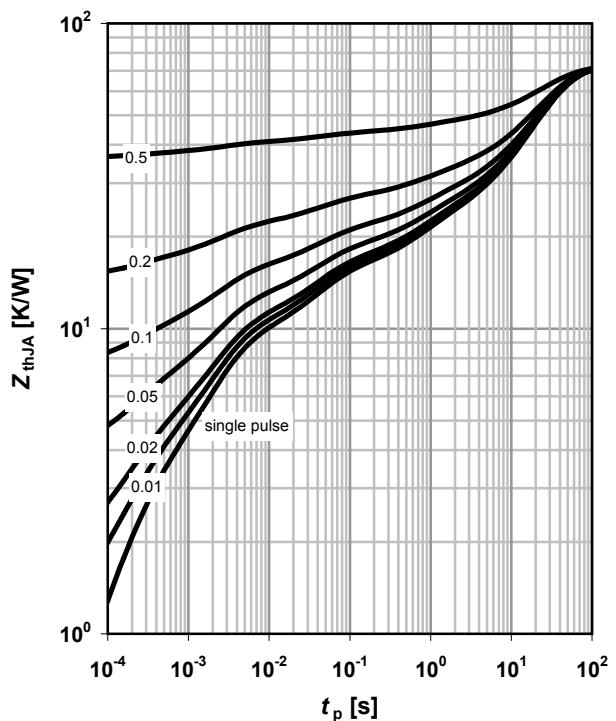
$$I_D = f(V_{DS}); T_A = 25 \text{ °C}; D = 0$$

parameter: t_p


4 Max. transient thermal impedance

$$Z_{\text{thJA}} = f(t_p)$$

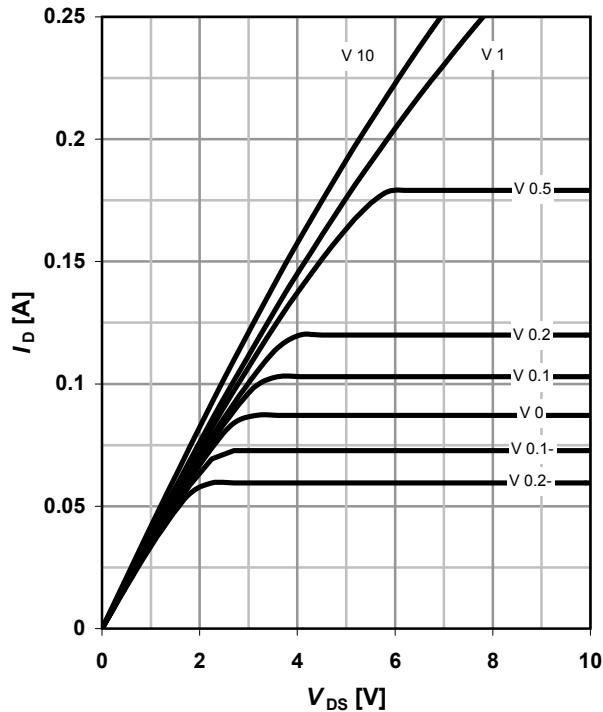
parameter: $D = t_p/T$



5 Typ. output characteristics

$I_D=f(V_{DS})$; $T_j=25\text{ }^\circ\text{C}$

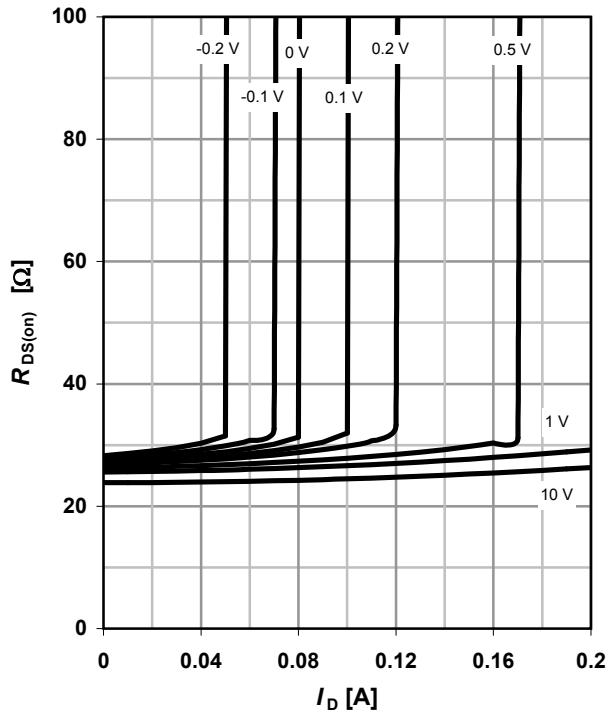
parameter: V_{GS}



6 Typ. drain-source on resistance

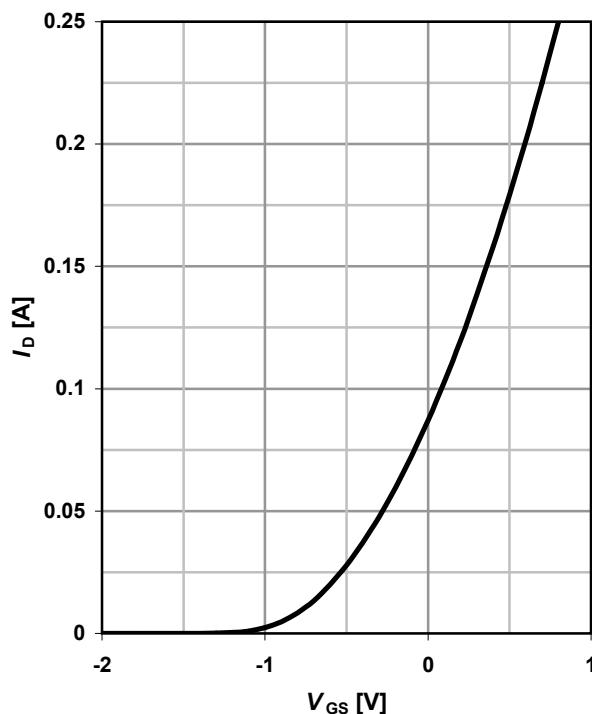
$R_{DS(on)}=f(I_D)$; $T_j=25\text{ }^\circ\text{C}$

parameter: V_{GS}



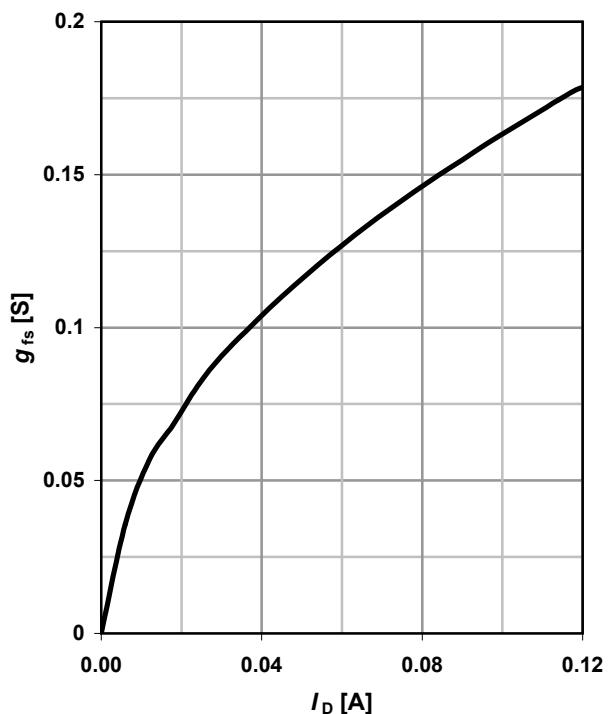
7 Typ. transfer characteristics

$I_D=f(V_{GS})$; $|V_{DS}|>2|I_D|R_{DS(on)max}$



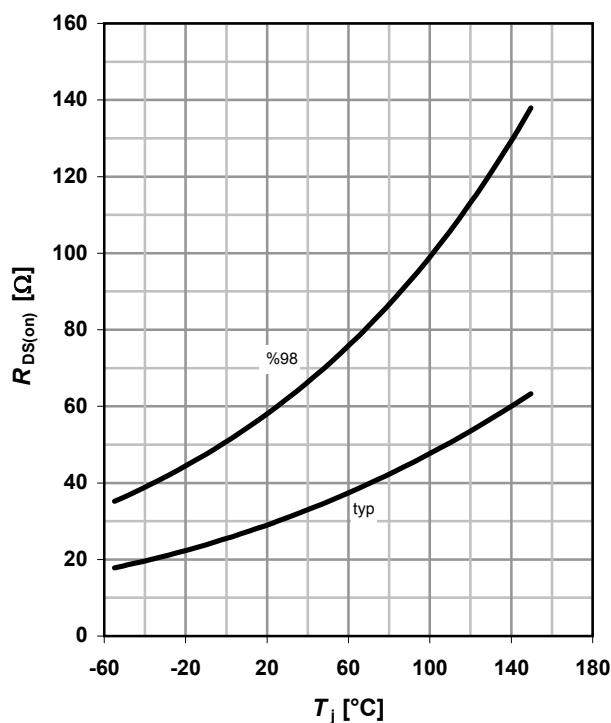
8 Typ. forward transconductance

$g_{fs}=f(I_D)$; $T_j=25\text{ }^\circ\text{C}$



9 Drain-source on-state resistance

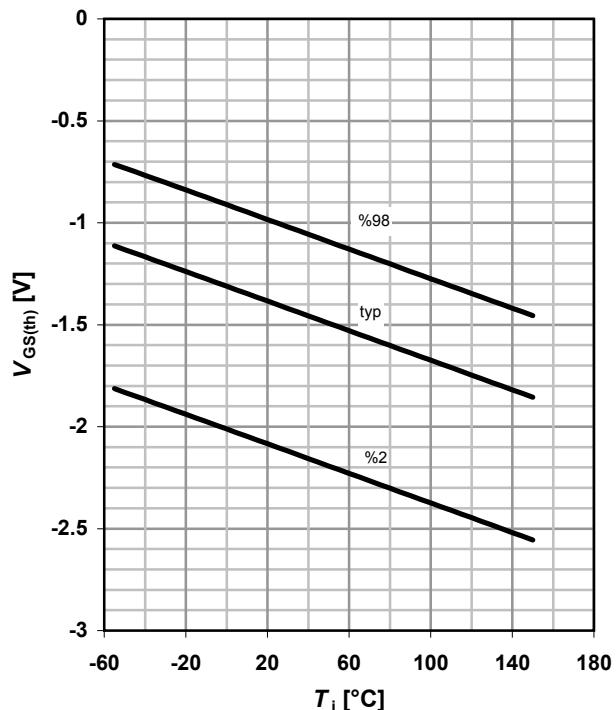
$R_{DS(on)} = f(T_j); I_D = 0.01 \text{ A}; V_{GS} = 0 \text{ V}$



10 Typ. gate threshold voltage

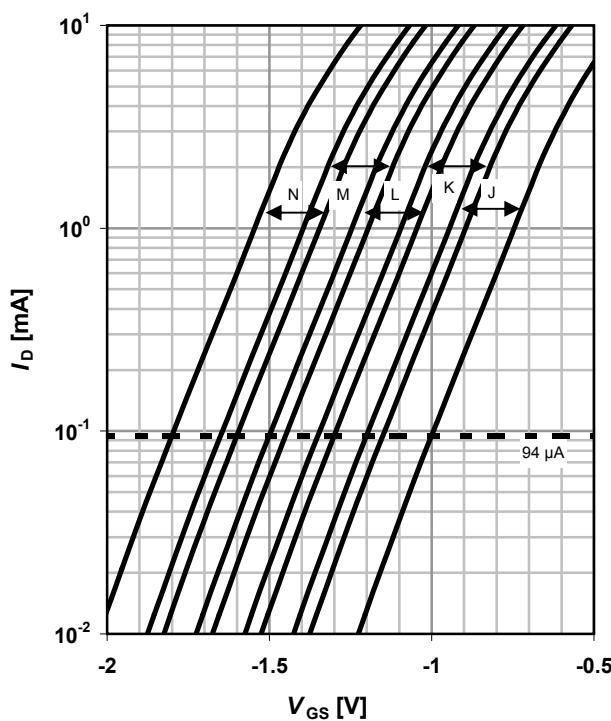
$V_{GS(th)} = f(T_j); V_{DS} = 3 \text{ V}; I_D = 94 \mu\text{A}$

parameter: I_D



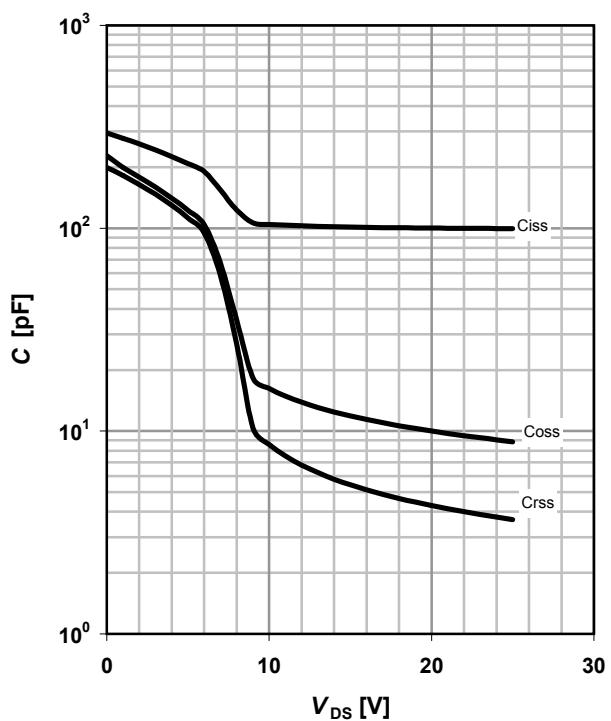
11 Threshold voltage bands

$I_D = f(V_{GS}); V_{DS} = 3 \text{ V}; T_j = 25 \text{ }^{\circ}\text{C}$



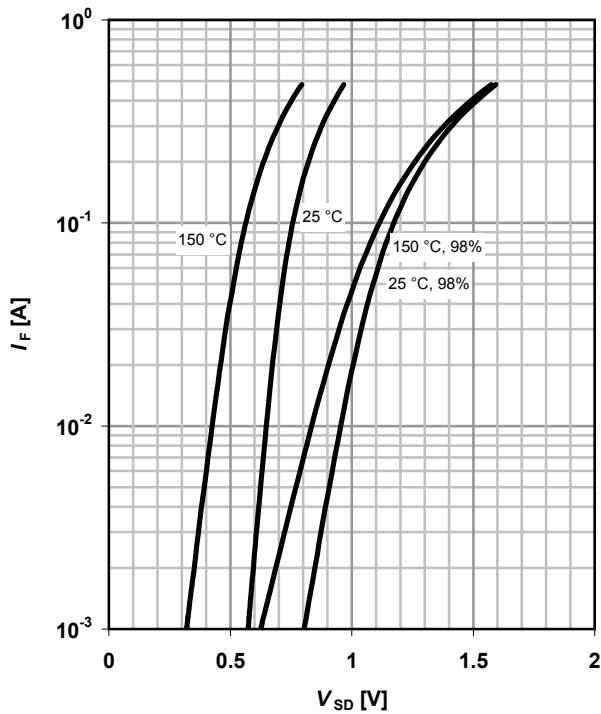
12 Typ. capacitances

$C = f(V_{DS}); V_{GS} = -3 \text{ V}; f = 1 \text{ MHz}$

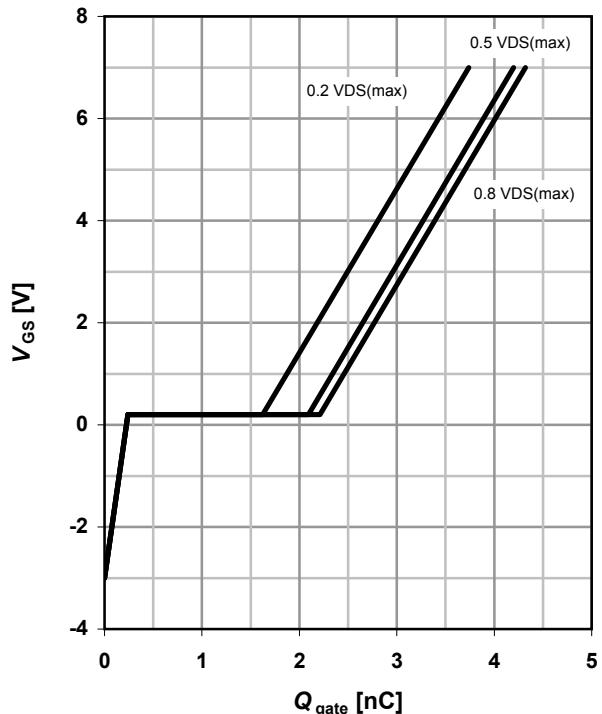


13 Forward characteristics of reverse diode

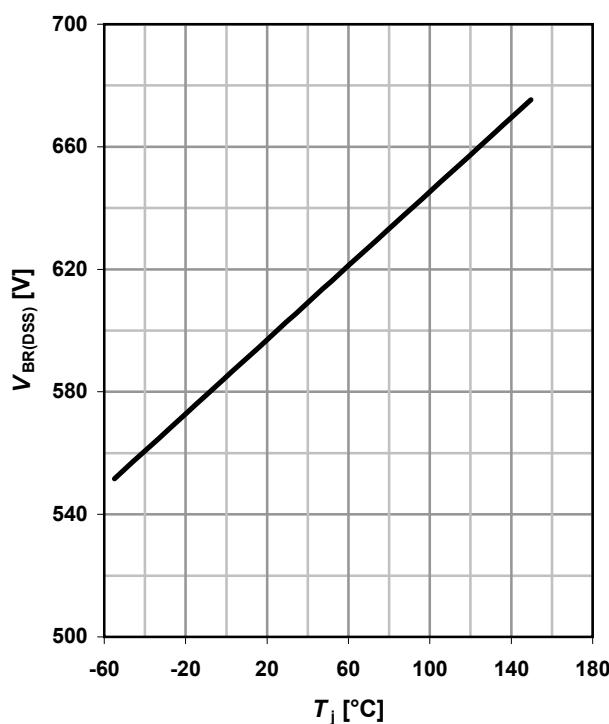
$$I_F = f(V_{SD})$$

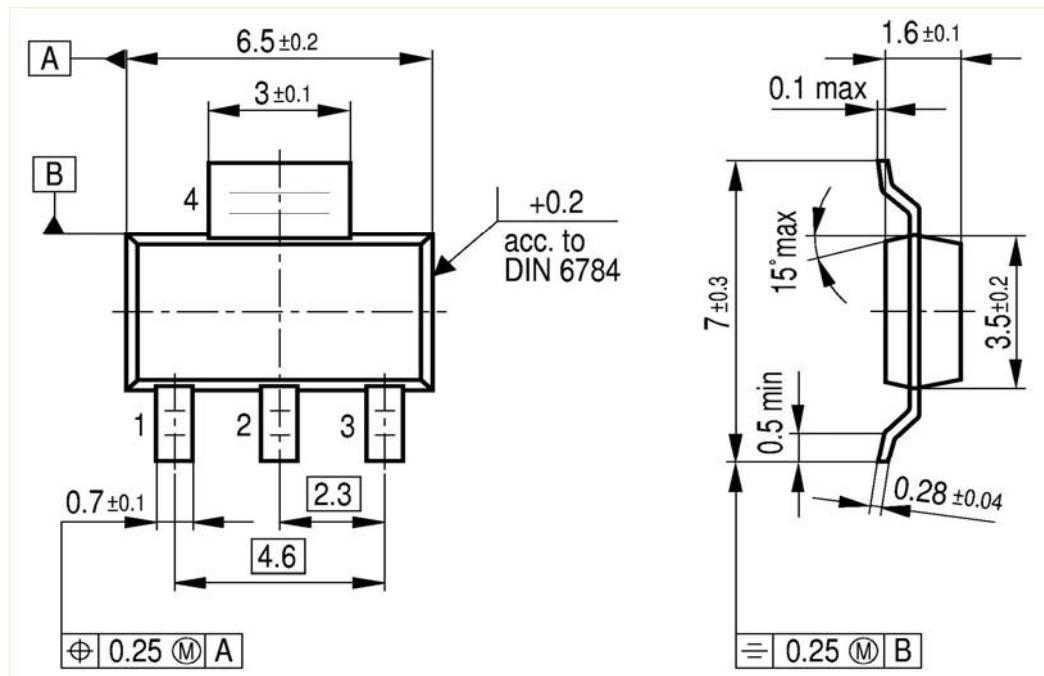
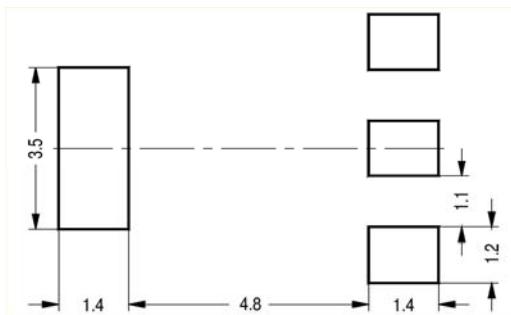
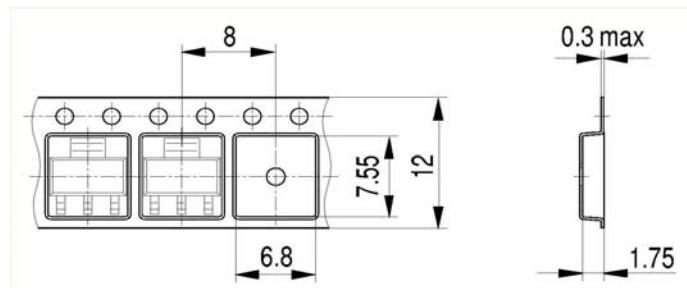
parameter: T_j

15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 0.1 \text{ A pulsed}$$

parameter: V_{DD}

16 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 250 \mu\text{A}$$



Package Outline:

Footprint:

Packaging:


Dimensions in mm

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